## TOSHIBA ALLOY-FREE LIGHT TRIGGER THYRISTOR

# **SL3000GX23**

#### HIGH POWER CONTROL APPLICATIONS

Repetitive Peak Off-State Voltage :  $V_{DRM}$  = 4000V

Repetitive Peak Reverse Voltage : VRRM

Average On-State Current  $: I_{T(AV)} = 3000A$ 

Light Trigger Power : PLT: 10mW (Max.)

Turn-Off Time :  $t_0 = 400 \mu s$  (Max.)

Critical Rate of Rise of On-State Current

:  $di/dt = 300A/\mu s$ 

Critical Rate of Rise of Off-State Voltage

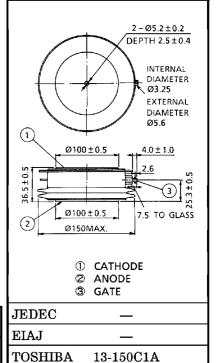
:  $dv/dt = 1500V/\mu s$ 

Flat Package

### MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Repetitive Peak Off-State Voltage and Repetitive Peak Reverse Voltage	${ m v_{DRM}} \ { m v_{RRM}}$	4000	V
Non-Repetitive Peak Reverse Voltage (Non-Repetitive $\leq 5$ ms, $T_j = 0 \sim 125$ °C)	$v_{RSM}$	4400	V
R.M.S On-State Current	I <sub>T</sub> (RMS)	4710	Α
Average On-State Current	I <sub>T</sub> (AV)	3000	Α
Peak One Cycle Surge On-State Current (Non-Repetitive)	ITSM	60000 (50Hz) 66000 (60Hz)	Α
I <sup>2</sup> t Limit Value	I <sup>2</sup> t	180×10 <sup>5</sup>	$\mathrm{A}^2\mathrm{s}$
Critical Rate of Rise of On-State Current (Note)	di / dt	300	A/μs
Junction Temperature	$T_{j}$	40~125	°C
Storage Temperature Range	$\mathrm{T_{stg}}$	40~125	°C
Mounting Force		$78.4 \pm 7.8$	kN

Unit in mm



Weight: 3200g

Note:  $V_D=1/2$  Rated,  $T_i=120$ °C

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# **ELECTRICAL CHARACTERISTICS**

CHARACTERISTIC	SYMBOL	TEST CONDITION		MIN.	MAX.	UNIT
Repetitive Peak Off-State Current and Repetitive Peak Reverse Current	IDRM IRRM	$V_{ m DRM} = V_{ m RRM} = { m Rated}$ $T_{ m j} = 125 { m ^{\circ}C}$		_	250	mA
Peak On-State Voltage	$ m V_{TM}$	$I_{TM} = 10000A, T_j = 25^{\circ}C$			2.5	V
Light Trigger Power	$P_{ m LT}$	$V_D=12V, R_L=6\Omega$	$T_j = -40$ °C		_	mW
			$T_j = 25$ °C		10	
Delay Time	$^{ m t_d}$	V <sub>D</sub> =1/2 Rated		_	5	$\mu$ s
Gate Turn-On Time	$ m t_{gt}$	$T_j=25$ °C, $P_L=20$ mw		_	10	$\mu$ s
Turn-Off Time	$\mathbf{t_q}$	$I_{T}$ =3000A, $V_{R}$ \ge 200V dv/dt=25V/\mu s, $T_{j}$ =125°C $V_{DRM}$ =1/2 Rated		_	400	μs
Holding Current	$I_{ m H}$	$T_j=25$ °C, $R_L=6\Omega$			300	mA
Critical Rate of Rise of Off-State Voltage	dv/dt	V <sub>DRM</sub> =1/2 Rated, T <sub>j</sub> =125°C Gate Open, Exponential Rise		1500	_	V/μs
Thermal Resistance (Junction to Case)	$ m R_{th(j-f)}$	DC		_	0.0075	°C/W

